

800V Super-junction Power MOSFET

Description

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Super-junction power MOSFET is a revolutionary technology for high voltage power MOSFETs, designed according to the SJ principle and pioneered. The Multi-EPI SJ MOSFET provide an extremely fast and robust body diode. Also provide an extremely low switching, communication and conduction losses device with highest robustness make especially resonant switching applications more reliable, more efficient, lighter and cooler, designed by Wuxi Unigroup Microelectronics Company.

Features		Applications			
Ultra-fast body diode		 Switch Mode Power Supply (SMPS) 			
● Very low FOM R _{DS(on)} ×Q _g		Uninterruptible Power Supply (UPS)			
• Easy to use/drive	 Easy to use/drive 		rrection (PFC)		
• 100% avalanche tested		LLC Half-bridge			
RoHS compliant	RoHS compliant		Low Power Chargers and Adapters		
TO-247		Drain			
G D S	Gate	Source	RoHS		
Device Marking and Package Information					
Device	Package		Marking		
TPW80R200MFD	TO-247		80R200MFD		
Key Performance Parameters					
Parameter	Value		Unit		
V _{DS} @ T _{j,max}	850		V		
R _{DS(on),max}	0.2		Ω		
Q _{g,typ}	56.7		nC		
I _D	23		A		
I _{D,pulse}	69		A		
E _{oss} @ 400V	4.9		μJ		
Body Diode di _F /dt	900		A/µs		
t _{rr}	149.5		ns		
Q _{rr}	0.98		μC		
Irrm	11.5		A		



Absolute Maximum Ratings $T_c = 25^{\circ}C$, unless otherwise noted						
Parameter			Symbol	Values	Unit	
Continuous Drain Current	T _C = 25°C		1	23	•	
	T _C = 100°C		н _о	13.8	А	
Pulsed Drain Current	(note	:1)	I _{D,pulse}	69	А	
Gate-Source Voltage			V_{GSS}	±30V	V	
Single Pulse Avalanche Energy (note2)		2)	E _{AS}	1125	mJ	
Repetitive Avalanche Energy (note2)		2)	E _{AR}	27.8	mJ	
Avalanche Current			I _{AR}	4.6	А	
MOSFET dv/dt Ruggedness, V_{DS}	= 0480V		dv/dt	50	V/ns	
Power Dissipation For TO-247			P _D	215	W	
Continuous Diode Forward Current			I _S	23	Δ	
Diode Pulsed Current (note1)		e1)	I _{S,pulse}	69	~	
Reverse Diode dv/dt (note3)		e3)	dv/dt	50	V/ns	
Maximum Diode Commutation Sp	peed (not	e3)	di _f /dt	900	A/µs	
Operating Junction and Storage	emperature Range		T _J , T _{stg}	-55~+150	°C	

Thermal Resistance For TO-247				
Parameter	Symbol	Value	Unit	
Thermal Resistance, Junction-to-Case	R _{thJC}	0.59	9C/M	
Thermal Resistance, Junction-to-Ambient	R _{thJA}	62.5	-0/00	



Electrical Characteristics $T_J = 25^{\circ}C$, unless otherwise noted						
Parameter	Cumhal	Tot One little	Value			
	Symbol	lest Conditions	Min.	Тур.	Max.	Unit
Static Characteristics		• •				
Drain-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0V, I_D = 250 \mu A$	800			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 800V, V _{GS} = 0V, T _J = 25°C			10	μA
Gate-Source Leakage Current	I _{GSS}	$V_{GS} = \pm 30V$			±100	nA
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	3		5	V
Drain-Source On-State-Resistance	R _{DS(on)}	V _{GS} = 10V , I _D = 11.5A		0.18	0.2	Ω
Gate Resistance	R _G	f = 1.0MHz open drain		1.6		Ω
Dynamic Characteristics		•				
Input Capacitance	C _{iss}	$\lambda = 0 \lambda$		2441.8		pF
Output Capacitance	C _{oss}	$V_{GS} = 0V,$ $V_{DS} = 100V$		59.94		
Reverse Transfer Capacitance	C _{rss}	t = 1.0MHZ		4.93		
Total Gate Charge	Qg	V = 640V		56.7		nC
Gate-Source Charge	Q _{gs}	$V_{DD} = 040V$, $I_D = 23A$,		12.2		
Gate-Drain Charge	Q_{gd}	$V_{GS} = 10V$		21.4		
Turn-on Delay Time	t _{d(on)}			56.7		
Turn-on Rise Time	t _r	$V_{DD} = 400V$		46.2		ns
Turn-off Delay Time	t _{d(off)}	$R_{\rm G} = 23A$ $R_{\rm G} = 25\Omega$		203		
Turn-off Fall Time	t _f			59		
Drain-Source Body Diode Characte	ristics		1			
Body Diode Forward Voltage	V_{SD}	$T_{J} = 25^{\circ}C, I_{SD} = 12A, V_{GS} = 0V$		0.9	1.5	V
Reverse Recovery Time	t _{rr}	V = 400V		149.5		ns
Reverse Recovery Charge	Q _{rr}	$V_R = 400V$ $I_F = 23A$		0.98		μC
Peak Reverse Recovery Current	l _{rrm}	ai _F /at = 100A/µs		11.5		А

Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. I_D = 10A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C
- 3. Identical low side and high side switch with identical ${\sf R}_{\sf G}$





Typical Characteristics $T_J = 25^{\circ}C$, unless otherwise noted





Typical Characteristics $T_J = 25^{\circ}C$, unless otherwise noted













Figure 10. Safe Operation Area For TO-247







Figure B: Resistive Switching Test Circuit and Waveform



Figure C: Unclamped Inductive Switching Test Circuit and Waveform







TO-247





·h'



SYMBOL	MIN	NOM	MAX			
А	4.90	5.00	5.10			
A1	2.31	2.41	2.51			
A2	1.90	2.00	2.10			
а	0		0.15			
a'	0		0.15			
b	1.16		1.26			
b1	1.15	1.2	1.22			
b2	1.96		2.06			
b3	1.95	2.00	2.02			
b4	2.96		3.06			
b5	2.96	3.00	3.02			
b6			2.25			
b7			3.25			
с	0.59		0.66			
c1	0.58	0.60	0.62			
D	20.90	21.00	21.10			
D1	16.25	16.55	16.85			
D2	1.05	1.17	1.35			
E	15.70	15.80	15.90			
E1	13.10	13.30	13.50			
E2	4.40	4.50	4.60			
E3	2.40	2.50	2.60			
e		5.436 BSC				
L	19.80	19.92	20.10			
L1			4.30			
М	0.35		0.95			
Ρ	3.40	3.50	3.60			
P1	7.00		7.40			
P2	2.40	2.50	2.60			
Q	5.60		6.00			
S	6.05	6.15	6.25			
Т	9.80		10.20			
U	6.00		6.40			



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